

| | | | | |
|-----------------------------------|---------------------------------------|--|-------------------------------------------------------------|-------------|
| Notice of References Cited | Application/Control No. 10/811,006 | | Applicant(s)/Patent Under Reexamination WILSON ET AL. | |
| | Examiner DON N. VO | | Art Unit 2611 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|-------------------|----------------|
| * | A | US-4,638,494 | 01-1987 | Kartchner et al. | 375/367 |
| * | B | US-5,022,049 | 06-1991 | Abrahamson et al. | 375/130 |
| * | C | US-2002/0181558 | 12-2002 | Ogawa et al. | 375/147 |
| * | D | US-2004/0057505 | 03-2004 | Valio, Harri | 375/148 |
| * | E | US-2005/0083901 | 04-2005 | Kim et al. | 370/342 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.